New Jersey Semi-Conductor Products, Inc.

20 STERN AVE.
SPRINGFIELD, NEW JERSEY 07081
U.S.A.

TELEPHONE: (201) 376-2922
(212) 227-6005
FAX: (201) 376-8960

MTP10N35
MTP10N40

Designer's Data Sheet

Power Field Effect Transistor

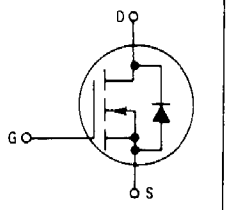
N-Channel Enhancement-Mode Silicon Gate TMOS

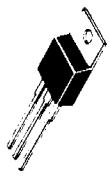
TMOS™

TMOS POWER FETs
10 AMPERES
$r_{DS(on)}$ = 0.55 OHM
350 and 400 VOLTS

These TMOS Power FETs are designed for medium voltage, high speed power switching applications such as switching regulators, converters, solenoid and relay drivers.

- Silicon Gate for Fast Switching Speeds — Switching Times Specified at 100°C
- Designer's Data — I_{DSS}, $V_{DS(on)}$, $V_{GS(th)}$ and SOA Specified at Elevated Temperature
- Rugged — SOA is Power Dissipation Limited
- Source-to-Drain Diode Characterized for Use With Inductive Loads





TO-220AB

MAXIMUM RATINGS

Rating	Symbol	MTP 10N35	MTP 10N40	Unit
Drain-Source Voltage	V_{DSS}	350	400	Vdc
Drain-Gate Voltage (R_{GS} = 1 MΩ)	V_{DGR}	350	400	Vdc
Gate-Source Voltage — Continuous — Non-repetitive ($t_p \leq 50\ \mu s$)	V_{GS} V_{GSM}	±20 ±40		Vdc Vpk
Drain Current Continuous Pulsed	 I_D I_{DM}	 10 40		Adc
Total Power Dissipation @ T_C = 25°C Derate above 25°C	P_D	125 1		Watts W/°C
Operating and Storage Temperature Range	T_J, T_{stg}	−65 to 150		°C

THERMAL CHARACTERISTICS

Thermal Resistance — Junction to Case — Junction to Ambient	$R_{\theta JC}$ $R_{\theta JA}$	1 62.5	°C/W
Maximum Lead Temperature for Soldering Purposes, 1/8" from case for 5 seconds	T_L	275	°C

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ELECTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise noted)

Characteristic		Symbol	Min	Max	Unit
OFF CHARACTERISTICS					
Drain-Source Breakdown Voltage (V_{GS} = 0, I_D = 0.25 mA)	MTP10N35 MTP10N40	$V_{(BR)DSS}$	 350 400	 — —	Vdc
Zero Gate Voltage Drain Current (V_{DS} = Rated V_{DSS}, V_{GS} = 0) (V_{DS} = 0.8 Rated V_{DSS}, V_{GS} = 0, T_J = 125°C)		I_{DSS}	— —	0.2 1	mAdc
Gate-Body Leakage Current, Forward (V_{GSF} = 20 Vdc, V_{DS} = 0)		I_{GSSF}	—	100	nAdc
Gate-Body Leakage Current, Reverse (V_{GSR} = 20 Vdc, V_{DS} = 0)		I_{GSSR}	—	100	nAdc
ON CHARACTERISTICS*					
Gate Threshold Voltage (V_{DS} = V_{GS}, I_D = 1 mA) T_J = 100°C		$V_{GS(th)}$	2 1.5	4.5 4	Vdc
Static Drain-Source On-Resistance (V_{GS} = 10 Vdc, I_D = 5 Adc)		$r_{DS(on)}$	—	0.55	Ohm
Drain-Source On-Voltage (V_{GS} = 10 V) (I_D = 10 Adc) (I_D = 5 Adc, T_J = 100°C)		$V_{DS(on)}$	 — —	 6 4.75	Vdc
Forward Transconductance (V_{DS} = 10 V, I_D = 5 A)		g_{FS}	4	—	mhos
DYNAMIC CHARACTERISTICS					
Input Capacitance	(V_{DS} = 25 V, V_{GS} = 0, f = 1 MHz) See Figure 11	C_{iss}	—	1600	pF
Output Capacitance		C_{oss}	—	350	
Reverse Transfer Capacitance		C_{rss}	—	150	
SWITCHING CHARACTERISTICS* (T_J = 100°C)					
Turn-On Delay Time	(V_{DD} = 25 V, I_D = 0.5 Rated I_D, R_{gen} = 50 ohms) See Figures 9, 13 and 14	$t_{d(on)}$	—	60	ns
Rise Time		t_r	—	150	
Turn-Off Delay Time		$t_{d(off)}$	—	200	
Fall Time		t_f	—	120	
Total Gate Charge	(V_{DS} = 0.8 Rated V_{DSS}, I_D = Rated I_D, V_{GS} = 10 V) See Figure 12	Q_g	40 (Typ)	60	nC
Gate-Source Charge		Q_{gs}	20 (Typ)	—	
Gate-Drain Charge		Q_{gd}	20 (Typ)	—	
SOURCE DRAIN DIODE CHARACTERISTICS*					
Forward On-Voltage	(I_S = Rated I_D, V_{GS} = 0)	V_{SD}	1.1 (Typ)	2	Vdc
Forward Turn-On Time		t_{on}	Limited by stray inductance		
Reverse Recovery Time		t_{rr}	600 (Typ)	—	ns
INTERNAL PACKAGE INDUCTANCE					
Internal Drain Inductance (Measured from the contact screw on tab to center of die) (Measured from the drain lead 0.25" from package to center of die)		L_d	 3.5 (Typ) 4.5 (Typ)	 — —	nH
Internal Source Inductance (Measured from the source lead 0.25" from package to source bond pad.)		L_s	7.5 (Typ)	—	

*Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.